

<b>Notice of References Cited</b>	Application/Control No. 10/049,397	Applicant(s)/Patent Under Reexamination ASCHIR ET AL.	
	Examiner Huy Q. Phan	Art Unit 2687	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,374,107 B1	04-2002	Boylan et al.	455/432.3
	B	US-6,101,387 A	08-2000	Granberg et al.	455/433
	C	US-2004/0248546 A1	12-2004	Bhaumick, Asesh	455/404.2
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 98/26615	06-1998	SE	Geulen, Eckhard	H04Q 7/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.